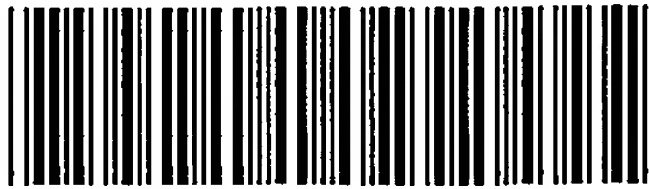


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/662,831	HASKELL ET AL.	
	Examiner	Art Unit	
	Cong-Lac Huynh	2178	

SEARCHED			
Class	Subclass	Date	Examiner
715	500.1	2/1/2006	CLH
	716	2/1/2006	CLH
	727	2/1/2006	CLH

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East	2/1/2006	CLH
ACM	2/1/2006	CLH
IEEE	2/1/2006	CLH
Google	2/1/2006	CLH